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Date Coverage

1976–present

Geographic Coverage

International

Publisher

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Japan

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- **PHYSICAL** (computing, information storage, measuring and testing, photography, optics)

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Monthly

Document Types

Patents

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SAMPLE DOCUMENT

TI
INV, PA
PBC, PN¹, PD

PARTIALLY COMPLEX MODULATED FILTER BANK

EKSTRAND PER; VILLEMoes LARS; PURNHAGEN HEIKO (Inventors). DOLBY INTERNATL AB (Assignee). **JP 2011102981 A**. (Published 26 May 2011).

Bibliographic information

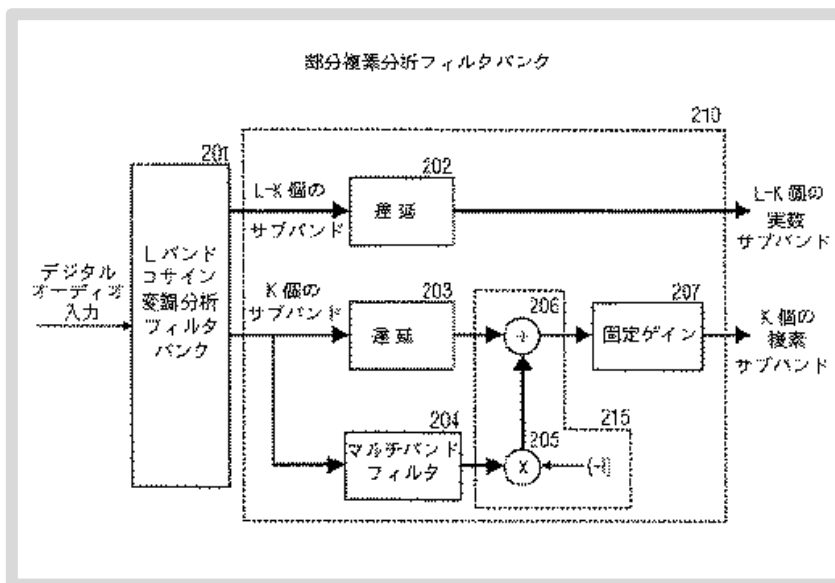
▣ **Abstract (summary)** [Translate](#)

AB

PROBLEM TO BE SOLVED: To provide an efficient concept for providing a signal allowing a manipulation with high quality and an efficient concept for reducing a signal in a state of less distortions.

SOLUTION: This invention relates to an apparatus 210 for processing a plurality of real-valued subband signals using a first real-valued subband signal and a second real-valued subband signal to provide at least a complex-valued subband signal. The apparatus comprises a multiband filter 204 for providing an intermediate real-valued subband signal, a calculator 215 for providing the complex-valued subband signal by combining a real-valued subband signal from the plurality of real-valued subband signals and the intermediate subband signal, and a delayer 203 for delaying the real-valued subband signal to supply the delayed real-valued subband signal to the calculator 215.

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▣ **Indexing (details)**

[Cite](#)

PA
INV

Assignee	DOLBY INTERNATL AB
Inventor	EKSTRAND PER VILLEMoes LARS PURNHAGEN HEIKO
Publication number	JP 2011102981 A (26 May 2011)
Application number	JP 2010254493 (15 November 2010)
Priority number	SE 20052049 (16 September 2005) US 2006463263 (08 August 2006)

PC, PN¹, PD
APC, APN¹, APD
PPC, PRN¹, PRD

¹ Also PNUM
Page 2

IPC	IPC classification	Version 8: G10L 19/02 (main) ; H03H 17/00 ; H03H 17/02 ; H03M 7/30 Fewer details ▲ IPC version 8:																																													
		<table border="1"> <thead> <tr> <th>Class code</th> <th>Level</th> <th>Value</th> <th>Position</th> <th>Status</th> <th>Version</th> <th>Action</th> <th>Source</th> <th>Office</th> </tr> </thead> <tbody> <tr> <td>G10L 19/02</td> <td>A</td> <td>I</td> <td>F</td> <td>B</td> <td>20060101</td> <td>20110428</td> <td>H</td> <td>JP</td> </tr> <tr> <td>H03H 17/00</td> <td>A</td> <td>I</td> <td>L</td> <td>B</td> <td>20060101</td> <td>20110428</td> <td>H</td> <td>JP</td> </tr> <tr> <td>H03H 17/02</td> <td>A</td> <td>I</td> <td>L</td> <td>B</td> <td>20060101</td> <td>20110428</td> <td>H</td> <td>JP</td> </tr> <tr> <td>H03M 7/30</td> <td>A</td> <td>I</td> <td>L</td> <td>B</td> <td>20060101</td> <td>20110428</td> <td>H</td> <td>JP</td> </tr> </tbody> </table>	Class code	Level	Value	Position	Status	Version	Action	Source	Office	G10L 19/02	A	I	F	B	20060101	20110428	H	JP	H03H 17/00	A	I	L	B	20060101	20110428	H	JP	H03H 17/02	A	I	L	B	20060101	20110428	H	JP	H03M 7/30	A	I	L	B	20060101	20110428	H	JP
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FAV	First available	2012-11-01																																													
UD	Updates	2012-11-01 2013-06-28 2013-07-02 2013-07-02 2013-07-05 2013-07-05																																													
PUB	Database	JAPIO - Patent Abstracts of Japan (1988 - current)																																													

SEARCH FIELDS

Field Name	Field Code	Example	Description and Notes
Abstract	AB	ab("multiband filter*")	Use adjacency and/or Boolean operators to narrow search results.
Abstract present	ABANY	abany(yes)	Add: <i>AND ABANY(YES)</i> to a query to limit retrieval to records with abstracts.
Accession number	AN	an(JP2011102981A)	A unique document identification number assigned by the information provider.
All fields	ALL	all(int*)	Searches all fields <i>except</i> the full text in full-text databases. Use proximity and/or Boolean operators to narrow search results.
All fields + text		int*	Searches all fields including the full text in full-text databases.
Any number	PNUM	pnum(jp 2011102981 a) pnum(2011102981) pnum(Includes publication, application, and priority application number. Enhanced/variant forms of the number are also searchable.
Application country	APC	apc(jp)	Includes application and priority application country
Application date	APD	apd(20101115) apd(201011) apd(2010)	Searches the main application date.
Application dates – all	APDA	apda(200509)	Includes application and priority application dates.
Application number	APN	apn(JP2010254493)	Searches the main application number.
Application numbers – all	APNA	apna(JP 2010254493 and se 20052049)	Includes application and, priority application numbers.
Author	AU	au(villemoes lars)	Author names in patent databases are inventors but g the AU field code.
Classification – IPC	IPC	ipc(H03H 17/02) ipc(H03H 17)	International Patent Class codes. Versions 1-7 and Version 8 are included.

Field Name	Field Code	Example	Description and Notes
		ipc(H03H) ipc(H03) ipc(H)	
Company information	CO	co(dolby)	Includes assignee or applicant
First available	FAV	fav(2012-11-01) fav(20121101)	Indicates the first time a document was loaded in a specific database. It will not change however many times the record is subsequently reloaded.
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Image present	IMGANY	imgany(yes)	Add: <i>AND IMGANY(YES)</i> to a query to limit your search to documents with an image.
Inventor	INV	inv(villemoes lars)	Inventor names are also searchable using the AU field code.
Language	LN	sl(english)	All JAPIO records are in English
Language of abstract	SL	sl(english)	
Patent assignee	PA	pa(dolby int*)	Includes assignee and assignee code.
Patent publication country	PBC	pbcc(jp)	Searches the 2-letter ISO standard country code for the main patent publication country.
Patent publication country and kind code	KC	kc(jp a) kc(jp)	The kind code indicates the publication level of a patent document. All JAPIO records are kind A.
Patent publication date	PD	pd(20110526) pd(201105) pd(>=2011)	Searches the main publication date. Also searchable via the Look Up Patent tool.
Patent publication number	PN	pn(JP2011102981)	Searches only the main publication number.
Patent title	TI	ti("complex modulated filter")	Includes patent title in English
Priority application country	PPC	ppc(us or se)	The 2-letter ISO-standard country code associated with the priority application number.
Priority application date	PRD	prd(20060808) ppc(se) lnk prd(20050916)	Searches the 8-digit date assigned to a priority application number
Priority application number	PRN	prn(us 2006463263)	The priority application number is the number assigned to the original or first application.
Publication title	PUB	pub(japio)	In a patent database, the publication title is generally the database name.
Publication type	PT	pt(government)	The only publication type in JAPIO is "Government & Official Publications".
Updates	UD	ud(20130705)	The date(s) the record was loaded as a result of an update provided by the supplier.

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SOURCES

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